

Search Notes

Application/Control No.

10/647,499

Examiner

German Colón

Applicant(s)/Patent under
Reexamination

PHELAN ET AL.

Art Unit

2879

SEARCHED

Class	Subclass	Date	Examiner
updated	previous search	10/27/2005	GC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
445	2,3,5,24	10/27/2005	GC
438	14		
356	630,237.1		
searched PGPubs for class/subclass above			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(438/4,7,10,14,16,17,29,99 or 356/73,301,302,326,335,451,630,237. 1) and:	10/27/2005	GC
test\$3 check\$3 inspect\$3 monitor\$3 measur\$3) and (defect\$3 deficiency imperfect\$3 failure flaw\$3 deformat\$3 deformity		
irregular\$3 damag\$3)		